

<b>Notice of References Cited</b>	Application/Control No. 10/539,891	Applicant(s)/Patent Under Reexamination NAPIER ET AL.	
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*	B	US-6,825,017	11-2004	Browse et al.	435/190
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	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Sayanova et al. 2006, FEBS Letters 580:1946-1952
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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